

### AON6454-VB Datasheet

## N-Channel 150 V (D-S) MOSFET

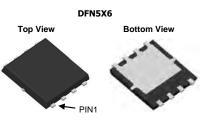
PRODUCT SUMMARY					
V <sub>DS</sub> (V)	R <sub>DS(on)</sub> (Ω) Max.	I <sub>D</sub> (A) <sup>g</sup>	Q <sub>g</sub> (Typ.)		
150	0.0158 at V <sub>GS</sub> = 10 V	53.7	22.8 nC		
150	0.0188 at V <sub>GS</sub> = 7.5 V	45	22.0110		

#### FEATURES

- Trench Power MOSFET
- 100 % R<sub>g</sub> and UIS Tested

#### APPLICATIONS

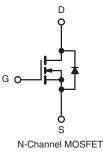
- Fixed Telecom
- DC/DC Converter
- Primary and Secondary Side Switch



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	. op 1.on		
	-		1
S [	1	8	D
S [	2	7	D
s [ s [ s [ G [	3	6	D
G	4	5	D

Top View



Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V <sub>DS</sub>	150	v	
Gate-Source Voltage		V <sub>GS</sub>	± 20	v	
	T <sub>C</sub> = 25 °C		53.7		
Continuous Drain Current (T <sub>.1</sub> = 150 °C)	T <sub>C</sub> = 70 °C	I <sub>D</sub>	43		
	T <sub>A</sub> = 25 °C	'D	12.8 <sup>b, c</sup>		
	T <sub>A</sub> = 70 °C		10.2 <sup>b, c</sup>	A	
Pulsed Drain Current (t = 300 µs)		I <sub>DM</sub>	130		
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C	la	60 <sup>a</sup>		
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	۱ <sub>S</sub>	5.6 <sup>b, c</sup>		
Single Pulse Avalanche Current L = 0.1 mH		I <sub>AS</sub>	30	-	
Single Pulse Avalanche Energy	L = 0.1 mm	E <sub>AS</sub>	45	mJ	
	T <sub>C</sub> = 25 °C		104		
Maximum Rower Dissinction	T <sub>C</sub> = 70 °C	P	66.6	w	
Maximum Power Dissipation	T <sub>A</sub> = 25 °C	P <sub>D</sub>	6.25 <sup>b, c</sup>	vv	
	T <sub>A</sub> = 70 °C		4 <sup>b, c</sup>		
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150		
Soldering Recommendations (Peak Temperature) <sup>d, e</sup>			260		

#### THERMAL RESISTANCE RATINGS

Parameter		Symbol	Typical	Maximum	Unit		
Maximum Junction-to-Ambient <sup>b, f</sup>	t ≤ 10 s	R <sub>thJA</sub>	15	20	°C/W		
Maximum Junction-to-Case (Drain)	Steady State	R <sub>thJC</sub>	0.9	1.2	0,11		

Notes:

a. Package limited.

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b. Surface mounted on 1" x 1" FR4 board.

c. t = 10 s.

d. The DFN5x6 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.

e. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.

f. Maximum under steady state conditions is 54 °C/W.

g. T<sub>C</sub> = 25 °C.



Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static	•,			.,,		
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA	150			V
V <sub>DS</sub> Temperature Coefficient	ΔV <sub>DS</sub> /T <sub>J</sub>			105		mV/°0
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I <sub>D</sub> = 250 μA		- 9.4		
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250 μA	2.0		4.0	V
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{GS} = \pm 20 V$	-		± 100	nA
	$V_{DS} = 150 \text{ V}, V_{CS} = 0 \text{ V}$		1	+		
Zero Gate Voltage Drain Current	IDSS	$V_{DS} = 150 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{J} = 70 \text{ °C}$			10	μA
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 V, V_{GS} = 10 V$	40			A
	D(011)	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 20 \text{ A}$	-	0.0158		
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	$V_{GS} = 7.5 \text{ V}, \text{ I}_{D} = 15 \text{ A}$		0.0188		Ω
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	$V_{\rm DS} = 10 \text{ V}, \text{ I}_{\rm D} = 20 \text{ A}$		30		S
Dynamic <sup>b</sup>	315				I	Ľ
Input Capacitance	C <sub>iss</sub>			1286		
Output Capacitance	C <sub>oss</sub>	V <sub>DS</sub> = 75 V, V <sub>GS</sub> = 0 V, f = 1 MHz		327		pF
Reverse Transfer Capacitance	C <sub>rss</sub>	$v_{\rm DS} = 75$ v, $v_{\rm GS} = 0$ v, $r = 1.0012$		-		
neverse transier Capacitance	Orss	V <sub>DS</sub> = 75 V, V <sub>GS</sub> = 10 V, I <sub>D</sub> = 20 A		28 31.3	47	
Total Gate Charge	Qg	$v_{\rm DS} = 73$ v, $v_{\rm GS} = 10$ v, $t_{\rm D} = 20$ A		22.8	35	-
Gate-Source Charge	Q <sub>gs</sub>	V <sub>DS</sub> = 75 V, V <sub>GS</sub> = 7.5 V, I <sub>D</sub> = 20 A		8		nC
Gate-Drain Charge	Q <sub>gd</sub>	$v_{\rm DS} = 70^{-1}$ , $v_{\rm GS} = 7.0^{-1}$ , $D = 20^{-1}$		10		
Output Charge		V <sub>DS</sub> = 75 V, V <sub>GS</sub> = 0 V		66	100	
Gate Resistance	R <sub>g</sub>	f = 1 MHz	0.3	1	2	Ω
Turn-On Delay Time	t <sub>d(on)</sub>		0.0	10	20	32
Rise Time	t <sub>r</sub>	$V_{DD} = 75 \text{ V}, \text{ R}_1 = 3.75 \Omega$		10	20	-
Turn-Off Delay Time	t <sub>d(off)</sub>	$V_{DD} = 73 V, H_{L} = 3.73 \Omega_{2}$ $I_{D} \cong 20 \text{ A}, V_{GEN} = 10 \text{ V}, H_{g} = 1 \Omega$		12	30	
Fall Time	t <sub>f</sub>	B - GEN - G		7	14	
Turn-On Delay Time				12	24	ns
Rise Time	t <sub>d(on)</sub> t <sub>r</sub>	V <sub>DD</sub> = 75 V, R <sub>I</sub> = 3.75 Ω		12	24	
Turn-Off Delay Time	t <sub>d(off)</sub>	$V_{DD} = 75 \text{ V}, \text{ H}_{L} = 3.75 \Omega$ $I_{D} \cong 20 \text{ A}, \text{ V}_{\text{GEN}} = 7.5 \text{ V}, \text{ H}_{a} = 1 \Omega$		13	34	_
Fall Time	t <sub>f</sub>			8	16	
Drain-Source Body Diode Characteristic	•			0	10	1
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C			60	
Pulse Diode Forward Current <sup>a</sup>	I <sub>SM</sub>	0			100	A
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = 5 A		0.77	1.1	v
, ,						
						ns
	-	$I_F = 20 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, \text{ T}_J = 25 ^\circ\text{C}$			000	nC
						ns
Body Diode Reverse Recovery Time   Body Diode Reverse Recovery Charge   Reverse Recovery Fall Time   Reverse Recovery Rise Time   Notes:	t <sub>rr</sub> Q <sub>rr</sub> t <sub>a</sub> t <sub>b</sub>	I <sub>F</sub> = 20 A, dl/dt = 100 A/μs, T <sub>J</sub> = 25 °C		2	95 280 72 23	280 560 72

a. Pulse test; pulse width  $\leq$  300  $\mu s,$  duty cycle  $\leq$  2 %.

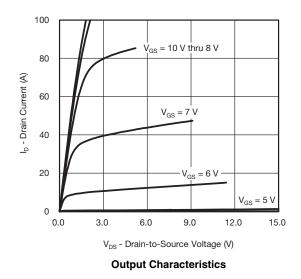
b. Guaranteed by design, not subject to production testing.

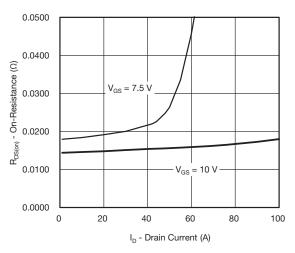
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Bsemi

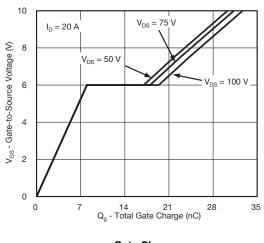
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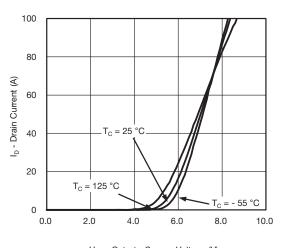




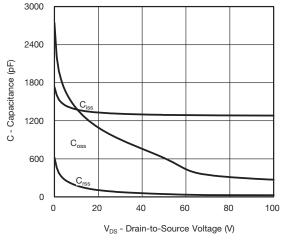
**On-Resistance vs. Drain Current** 



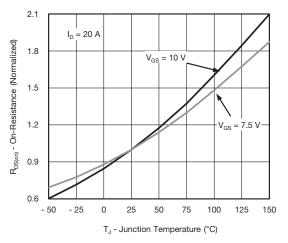
Gate Charge



V<sub>GS</sub> - Gate-to-Source Voltage (V) Transfer Characteristics

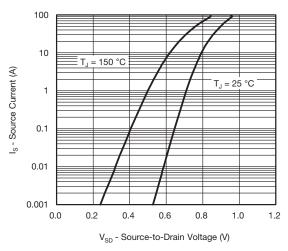


Capacitance

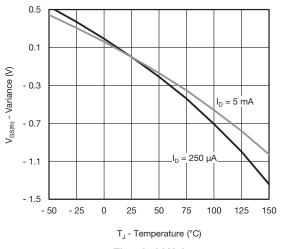


**On-Resistance vs. Junction Temperature** 

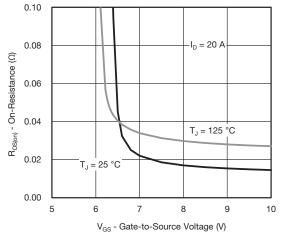




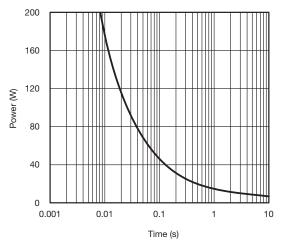




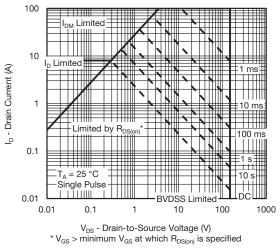




On-Resistance vs. Gate-to-Source Voltage

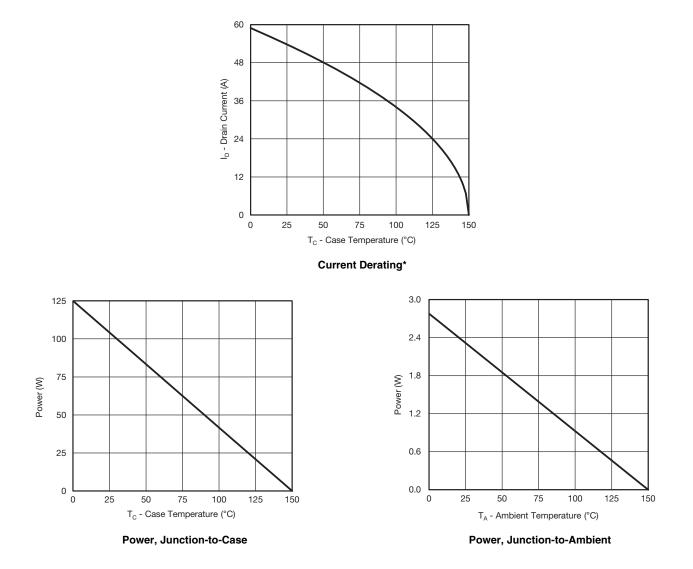


Single Pulse Power, Junction-to-Ambient



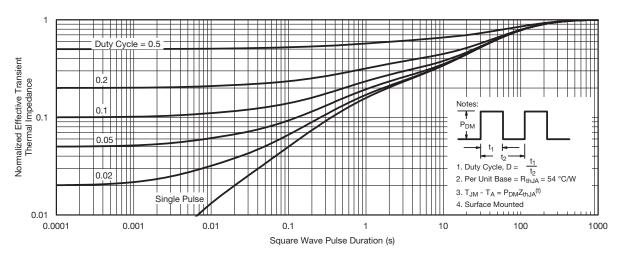
Safe Operating Area, Junction-to-Ambient



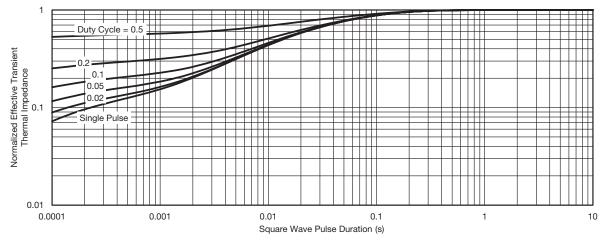


\* The power dissipation  $P_D$  is based on  $T_{J(max.)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





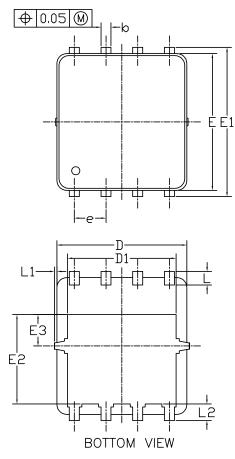
Normalized Thermal Transient Impedance, Junction-to-Ambient



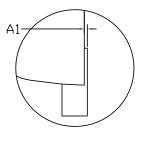
Normalized Thermal Transient Impedance, Junction-to-Case







Δ



<u>VIEW 'A'</u> (SCALE 5:1)

RECOMMENDED LAND PATTERN 0.50 + + + 0.77 + 0.55 0.50 + + + + + 0.635 + 4.12 1.60 + + + + + 0.65 0.50 - + - + 1.27 - +

SYMBOLS	DIMENSIONS IN MILLIMETERS			DIMENSIONS IN INCHES			
SIMBOLS	MIN	NOM	MAX	MIN	NOM	MAX	
A	0.85	0.95	1.00	0.033	0.037	0.039	
A1	0.00		0.05	0.000		0.002	
b	0.30	0.40	0.50	0.012	0.016	0.020	
c	0.15	0.20	0.25	0.006	0.008	0.010	
D	5.10	5.20	5.30	0.201	0.205	0.209	
D1	4.25	4.35	4.45	0.167	0.171	0.175	
E	5.45	5.55	5.65	0.215	0.219	0.222	
E1	5.95	6.05	6.15	0.234	0.238	0.242	
E2	3.525	3.625	3.725	0.139	0.143	0.147	
E3	1.175	1.275	1.375	0.046	0.050	0.054	
e	1.27 BSC			0.050 BSC			
L	0.45	0.55	0.65	0.018	0.022	0.026	
L1	0		0.15	0		0.006	
L2	0.68 REF			0.027 REF			
θ	0°		10°	0°		10°	

NOTE

UNIT: mm

1. PACKAGE BODY SIZES EXCLUDE MOLD FLASH AND GATE BURRS.

MOLD FLASH AT THE NON-LEAD SIDES SHOULD BE LESS THAN 6 MILS EACH. 2. CONTROLLING DIMENSION IS MILLIMETER.

CONVERTED INCH DIMENSIONS ARE NOT NECESSARILY EXACT.



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